## Notice of References Cited

		<u>/</u>	
	Application/Control No.	Applicant(s)/Pater	nt Under
	09/840,490	Reexamination NAKAMURA ET	AL.
İ	Examiner	Art Unit	
	<b>X</b> uan <b>M</b> Thai	218	Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,529,977	03-2003	Nyu, Takayuki	710/100
	. В	US-6,513,085	01-2003	Gugel et al.	710/305
	С	US-6,430,225	08-2002	Okawa et al.	375/242
,	D	US-6,347,097	02-2002	Deng, Brian T.	370/498
	E	US-6,157,972	12-2000	Newman et al.	710/100
	F	US-5,802,301	09-1998	Dan et al.	709/223
	G	US-5,802,289	09-1998	Oprescu, Florin	709/248
	Н	US-5,802,048	09-1998	Duckwall, William S.	370/389
	-	US-5,768,250	06-1998	Albrecht, Alan R.	370/216
	٦	US-5,729,541	03-1998	Hamalainen et al.	370/337
	К	US-5,604,735	02-1997	Levinson et al.	370/360
	L	US-5,519,709	05-1996	Albrecht et al.	370/407
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q			7-1-2		
	R					
	s					
	Т					

## NON-PATENT DOCUMENTS

	NON-PATENT DOCUMENTS			
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
•	U			
	٧			
	W			
	x			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)